

<b>Notice of References Cited</b>	Application/Control No. 10/655,307		Applicant(s)/Patent Under Reexamination LEE, SHIN-SANG	
	Examiner Rakesh K. Dhingra		Art Unit 1763	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,953,515	10-2005	Boyd et al.	156/345.16
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 07099184 A	04-1995	Japan	EGUCHI, KAZUO	H01L 21/3065
	O	KR 2002009190 A	02-2002	Korea, Republic	KIM et al.	H01L 21/306
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.